

CMOS Dual Complementary Pair Plus Inverter

High-Voltage Types (20-Volt Rating)

- CD4007UB types are comprised of three n-channel and three p-channel enhancement-type MOS transistors. The transistor elements are accessible through the package terminals to provide a convenient means for constructing the various typical circuits as shown in Fig. 2.

More complex functions are possible using multiple packages. Numbers shown in parentheses indicate terminals that are connected together to form the various configurations listed.

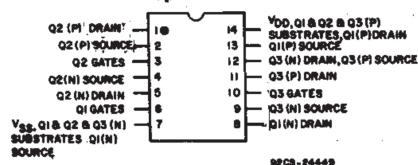
The CD4007UB types are supplied in 14-lead hermetic dual-in-line ceramic packages (F3A suffix), 14-lead dual-in-line plastic packages (E suffix), 14-lead small-outline packages (M, MT, M96, and NSR suffixes), and 14-lead thin shrink small-outline packages (PW and PWR suffixes).

Applications:

- Extremely high-input impedance amplifiers
- Shapers
- Inverters
- Threshold detector
- Linear amplifiers
- Crystal oscillators

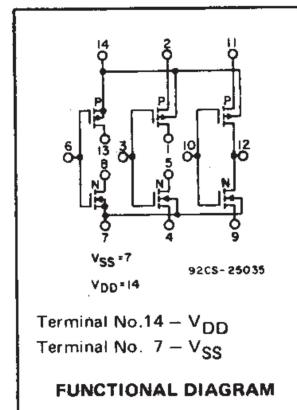
TERMINAL DIAGRAM

Top View



Features:

- Standardized symmetrical output characteristics
- Medium Speed Operation – $t_{PHL} = t_{PLH} = 30\text{ ns}$ (typ.) at 10 V
- 100% tested for quiescent current at 20 V
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"
- Maximum input current of 1 μA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C



RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIMITS		UNITS
	MIN.	MAX.	
Supply-Voltage Range (For $T_A = \text{Full Package Temperature Range}$)	3	18	V

STATIC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)						UNITS	
	V_O (V)	V_{IN} (V)	V_{DD} (V)	+25				Min.	Typ.	Max.	
				-55	-40	+85	+125				
Quiescent Device Current, I_{DD} Max.	–	0,5	5	0,25	0,25	7,5	7,5	–	0,01	0,25	μA
	–	0,10	10	0,5	0,5	15	15	–	0,01	0,5	
	–	0,15	15	1	1	30	30	–	0,01	1	
	–	0,20	20	5	5	150	150	–	0,02	5	
Output Low (Sink) Current I_{OL} Min.	0,4	0,5	5	0,64	0,61	0,42	0,36	0,51	1	–	mA
	0,5	0,10	10	1,6	1,5	1,1	0,9	1,3	2,6	–	
	1,5	0,15	15	4,2	4	2,8	2,4	3,4	6,8	–	
Output High (Source) Current, I_{OH} Min.	4,6	0,5	5	-0,64	-0,61	-0,42	-0,36	-0,51	-1	–	mA
	2,5	0,5	5	-2	-1,8	-1,3	-1,15	-1,6	-3,2	–	
	9,5	0,10	10	-1,6	-1,5	-1,1	-0,9	-1,3	-2,6	–	
	13,5	0,15	15	-4,2	-4	-2,8	-2,4	-3,4	-6,8	–	
Output Voltage: Low-Level, V_{OL} Max.	–	0,5	5	0,05				–	0	0,05	V
	–	0,10	10	0,05				–	0	0,05	
	–	0,15	15	0,05				–	0	0,05	
Output Voltage: High-Level, V_{OH} Min.	–	0,5	5	4,95				4,95	5	–	V
	–	0,10	10	9,95				9,95	10	–	
	–	0,15	15	14,95				14,95	15	–	
Input Low Voltage, V_{IL} Max.	4,5	–	5	1				–	–	1	V
	9	–	10	2				–	–	2	
	13,5	–	15	2,5				–	–	2,5	
Input High Voltage, V_{IH} Min.	0,5	–	5	4				4	–	–	V
	1	–	10	8				8	–	–	
	1,5	–	15	12,5				12,5	–	–	
Input Current I_{IN} Max.		0,18	18	$\pm 0,1$	$\pm 0,1$	± 1	± 1	–	$\pm 10^{-5}$	$\pm 0,1$	μA

CD4007UB Types

MAXIMUM RATINGS, Absolute-Maximum Values:
DC SUPPLY-VOLTAGE RANGE, (V_{DD})

Voltages referenced to V_{SS} Terminal -0.5V to +20V

INPUT VOLTAGE RANGE, ALL INPUTS

..... -0.5V to V_{DD} +0.5V

DC INPUT CURRENT, ANY ONE INPUT

..... $\pm 10\text{mA}$

POWER DISSIPATION PER PACKAGE (P_D)

For $T_A = -55^\circ\text{C}$ to $+100^\circ\text{C}$ 500mW

For $T_A = +100^\circ\text{C}$ to $+125^\circ\text{C}$ Derate Linearity at $12\text{mW}/^\circ\text{C}$ to 200mW

DEVICE DISSIPATION PER OUTPUT TRANSISTOR

FOR $T_A = \text{FULL PACKAGE-TEMPERATURE RANGE (All Package Types)}$ 100mW

OPERATING-TEMPERATURE RANGE (T_A) -55 $^\circ\text{C}$ to +125 $^\circ\text{C}$

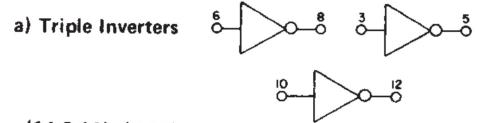
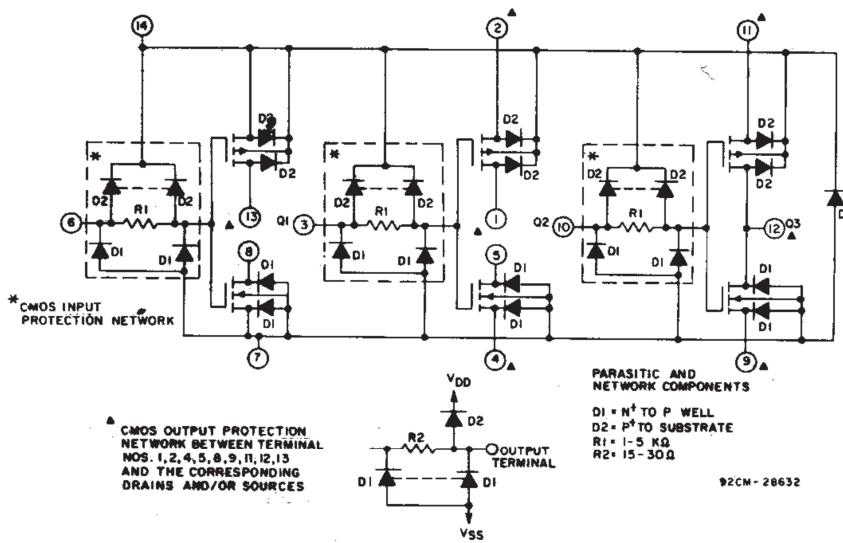
STORAGE TEMPERATURE RANGE (T_{stg}) -65 $^\circ\text{C}$ to +150 $^\circ\text{C}$

LEAD TEMPERATURE (DURING SOLDERING):

At distance $1/16 \pm 1/32$ inch ($1.59 \pm 0.79\text{mm}$) from case for 10s max +265 $^\circ\text{C}$

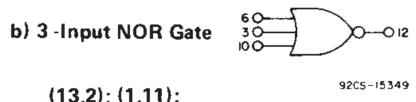
DYNAMIC ELECTRICAL CHARACTERISTICS at $T_A = 25^\circ\text{C}$; Input $t_r, t_f = 20\text{ ns}$, $C_L = 50\text{ pF}$, $R_L = 200\text{ k}\Omega$

CHARACTERISTIC	CONDITIONS	LIMITS		UNITS
		V _{DD} Volts	Typ.	
Propagation Delay Time:	t_{PHL}, t_{PLH}	5	55	110
		10	30	60
		15	25	50
Transition Time	t_{THL}, t_{TLH}	5	100	200
		10	50	100
		15	40	80
Input Capacitance	C_{IN}	Any Input	10	15
				pF



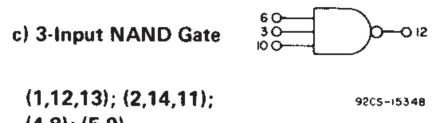
(14,2,11); (8,13);
(1,5); (7,4,9)

92CS-15350



(13,2); (1,11);
(12,5,8); (7,4,9)

92CS-15349



(1,12,13); (2,14,11);
(4,8); (5,9)

92CS-15348

d) Tree (Relay) Logic

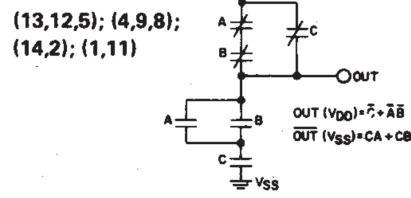
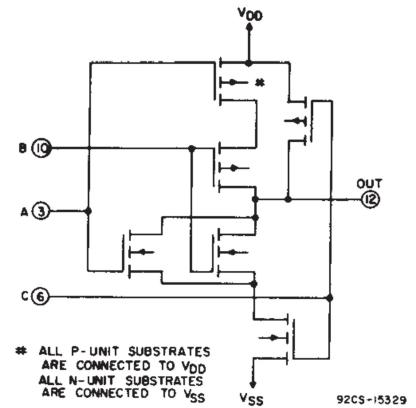
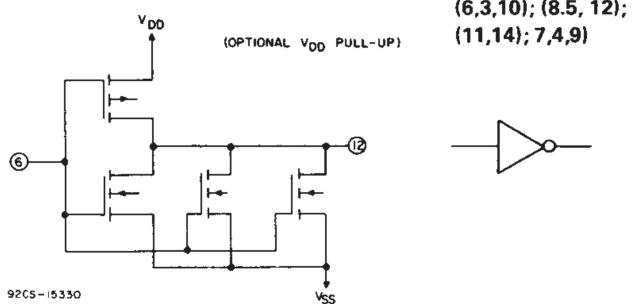


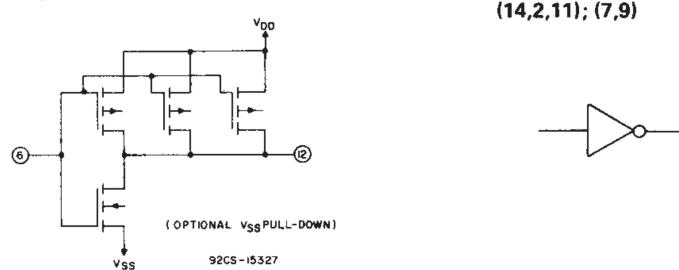
Fig. 2 – Sample CMOS logic circuit arrangements using type CD4007UB.

CD4007UB Types

e) High Sink-Current Driver



f) High Source-Current Driver



g) High Sink - and Source-Current Driver

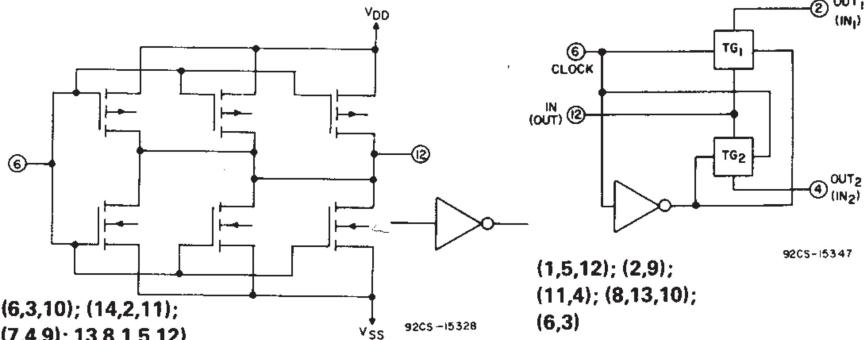
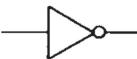
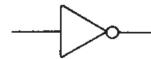


Fig. 2 – Sample CMOS logic circuit arrangements using type CD4007UB (Cont'd).

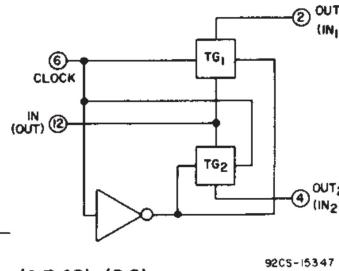
(6,3,10); (8.5, 12);
(11,14); 7,4,9



(6,3,10); (13,1,12);
(14,2,11); (7,9)



h) Dual Bi-Directional Transmission Gating



(1,5,12); (2,9);
(11,4); (8,13,10);
(6,3)

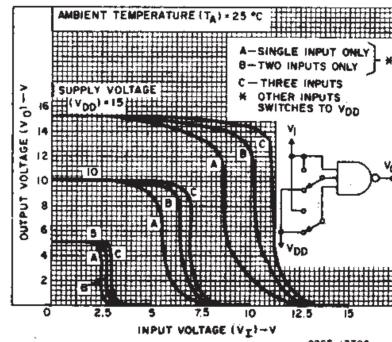


Fig. 3 – Typical voltage-transfer characteristics for NAND gate.

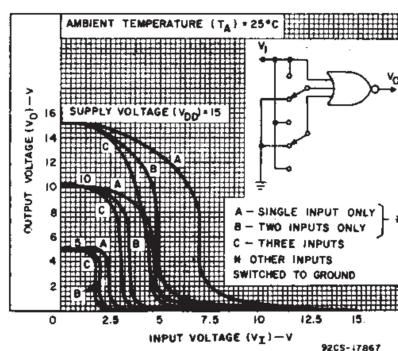


Fig. 4 – Typical voltage-transfer characteristics for NOR gate.

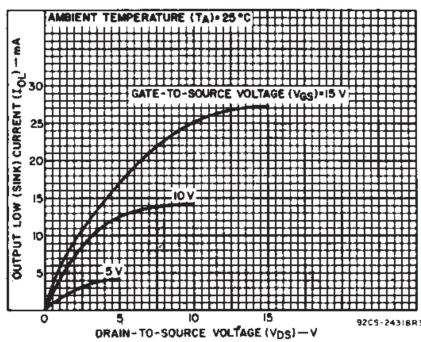


Fig. 5 – Typical output low (sink) current characteristics.

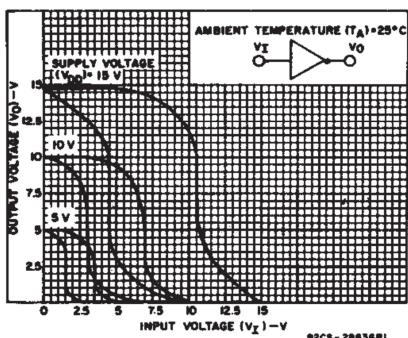


Fig. 6 – Minimum and maximum voltage-transfer characteristics for inverter.

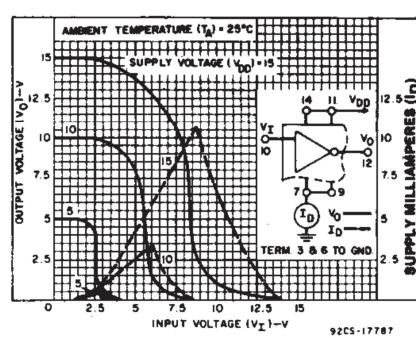


Fig. 7 – Typical current and voltage-transfer characteristics for inverter.

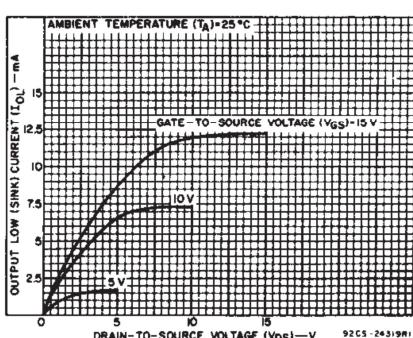


Fig. 8 – Minimum output low (sink) current characteristics.

CD4007UB Types

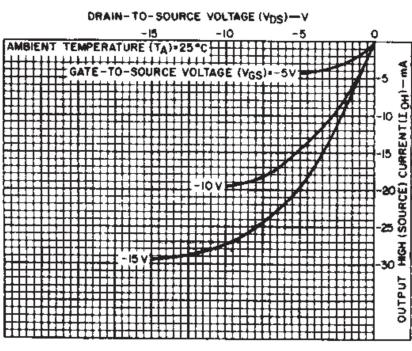


Fig. 9 — Typical output high (source) current characteristics.

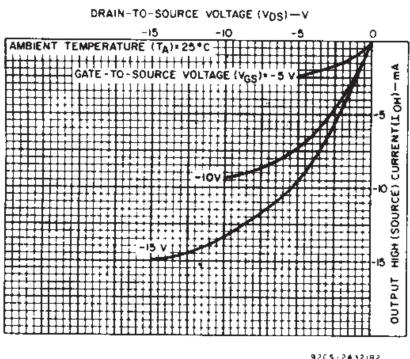


Fig. 10 — Minimum output high (source) current characteristics.

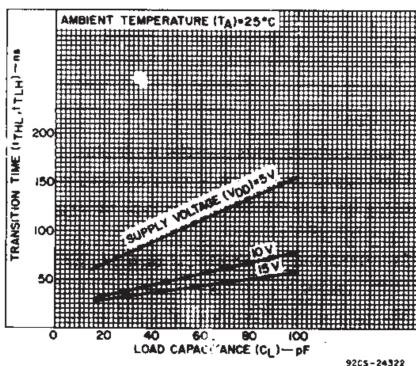


Fig. 13 — Typical transition time vs. load capacitance.

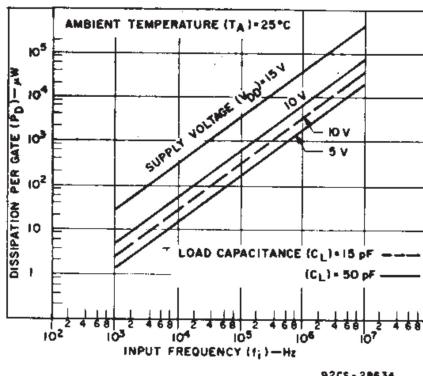


Fig. 14 — Typical dissipation vs. frequency characteristics.

